

<b>Notice of References Cited</b>			Application/Control No. 09/656,894	Applicant(s)/Patent Under Reexamination RAITH, ALEX KRISTER	
			Examiner LEE NGUYEN	Art Unit 2683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country-Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,786,789	07-1998	Janky	342/357
	B	US-6,085,090	07-0200	Yee et al.	455/440
	C	US-6,362,783	03-2002	Sugiura et al.	342/457
	D	US-2003/0036389	02-2002	Yen	455/456
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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